onsemi

MOSFET – Power, N-Channel

80 V, 1.75 mΩ

NVCR4LS1D7N08M7A

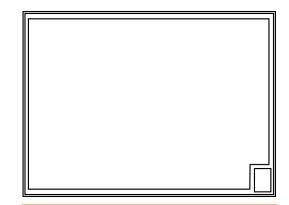
Features

- Typical $R_{DS(on)} = 1.31 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$
- Typical $Q_{g(tot)} = 130 \text{ nC}$ at $V_{GS} = 10 \text{ V}$
- AEC-Q101 Qualified
- RoHS Compliant

DIMENSION (µm)

Die Size	5080×3683
Die Size (Sawn)	$5060 \pm\!\!15 \!\times\! 3663 \pm\!\!15$
Source Attach Area	4874.7 × 3453.5
Gate Attach Area	359.9×483.5
Die Thickness	101.6 ±19.1

Gate and Source: AlSiCu Drain: Ti–NiV–Ag (back side of die) Passivation: Polyimide Wafer Diameter: 8 inch Wafer Sawn on UV Tape Bad Dice Identified in Inking Gross Die Counts: 1362



ORDERING INFORMATION

Device	Package
NVCR4LS1D7N08M7A	Wafer
	Sawn on Foil

RECOMMENDED STORAGE CONDITIONS

Temperature	22 to 28°C
RH	40 to 66%

The Chip is 100% Probed to Meet the Conditions and Limits Specified at $T_J = 25^{\circ}$ C.

Symbol	Parameter	Condition	Min	Тур	Мах	Unit
BV _{DSS}	Drain to Source Breakdown Voltage	I_D = 250 μ A, V_{GS} = 0 V	80	-	-	V
I _{DSS}	Drain to Source Leakage Current	$V_{DS} = 80 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	-	-	1	μΑ
I _{GSS}	Gate to Source Leakage Current	V_{GS} = ±20 V, V_{DS} = 0 V	-	-	±100	nA
V _{GS(th)}	Gate to Source Threshold Voltage	V_{GS} = V_{DS} , I_D = 250 μ A	2.0	-	4.0	V
*R _{DS(on)}	Bare Die Drain to Source On Resistance	I _D = 5 A, V _{GS} = 10 V	-	1.31	1.75	mΩ
V_{SD}	Source to Drain Diode Voltage	I_{SD} = 5 A, V_{GS} = 0 V	-	-	1.2	V
E _{AS}	Single Pulse Drain-to-Source Avalanche Energy	L = 0.17 mH, I _{AS} = 70 A	416	-	-	mJ

*Accurate R_{DS(on)} test at die level is not feasible for this thin die as limited by the test contact precision attainable in a die form. The max R_{DS(on)} specification is defined from the historical performance of the die in package but is not guaranteed by test in production. The die R_{DS(on)} performance depends on the Source wire/ribbon bonding layout.

MOSFET MAXIMUM RATINGS in Reference to the FDBL86363-F085 electrical data in TOLL

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

Symbol	Parameter	Ratings	Unit
V _{DSS}	Drain to Source Voltage	80	V
V _{GS}	Gate to Source Voltage	±20	V
Ι _D	Continuous Drain Current $R_{\theta JC}$ (V _{GS} = 10) (Note 1) T _C = 25°C T _C = 100°C	295 208	A
E _{AS}	Single Pulse Avalanche Energy (Note 2)	512	mJ
PD	Power Dissipation $R_{\theta JC}$	357	W
	Derate Above 25°C	2.38	W/°C
T _J , T _{STG}	Operating and Storage Temperature	-55 to +175	°C
R_{\thetaJC}	Thermal Resistance, Junction to Case	0.42	°C/W
$R_{\theta JA}$	Maximum Thermal Resistance, Junction to Ambient (Note 3)	43	°C/W

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Current is limited by silicon.

 Starting T_J = 25°C, L = 0.25 mH, I_{AS} = 64 A, V_{DD} = 80 V during inductor charging and V_{DD} = 0 V during time in avalanche.
R_{θJA} is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{θJC} is guaranteed by design, while R_{θJA} is determined by the board design. The maximum rating presented here is based on mounting on a 1 in² pad of 2oz copper.

ELECTRICAL CHARACTERISTICS in Reference to the FDBL86363-F085 electrical data in TOLL

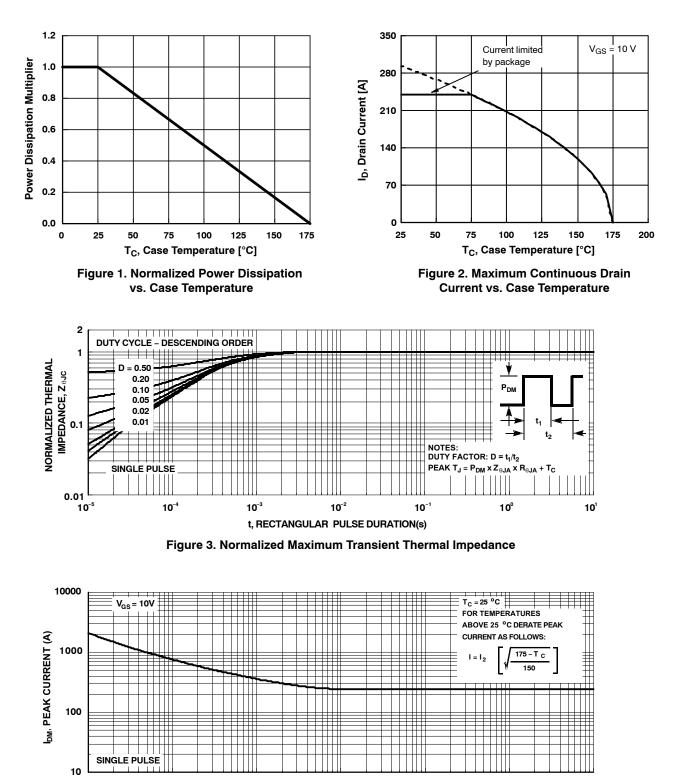
(T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
OFF CHARAC	TERISTICS		•	-		
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$	80	-	-	V
I _{DSS}	Drain to Source Leakage Current	$V_{DS} = 80 V$, $T_{J} = 25^{\circ}C$	-	_	1	μA
		$V_{GS}^{OS} = 0 V$ $T_{J} = 175^{\circ}C \text{ (Note 4)}$	- 4)	-	1	mA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}$	-	-	±100	nA
ON CHARAC	TERISTICS					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250 \ \mu A$	2.0	3.0	4.0	V
R _{DS(on)}	Drain to Source on Resistance	$I_D = 80 \text{ A}, T_J = 25^{\circ}\text{C}$	-	1.5	2.0	mΩ
		V _{GS} = 10 V T _J = 175°C (Note 4)	- 4) –	3.1	4.1	mΩ
OYNAMIC CH	ARACTERISTICS					
C _{iss}	Input Capacitance	V_{DS} = 40 V, V_{GS} = 0 V, f = 1 MHz	-	10000	-	pF
Coss	Output Capacitance		-	1540	-	pF
C _{rss}	Reverse Transfer Capacitance		-	70	-	pF
Rg	Gate Resistance	f = 1 MHz	-	2.8	-	Ω
Q _{g(ToT)}	Total Gate Charge	V_{GS} = 0 to 10 V, V_{DD} = 64 V, I_D = 8	0 A –	130	-	nC
Q _{g(th)}	Threshold Gate Charge	V_{GS} = 0 to 2 V, V_{DD} = 64 V, I_D = 80	Α –	18	-	nC
Q _{gs}	Gate to Source Gate Charge	V _{DD} = 64 V, I _D = 80 A	-	47	-	nC
Q _{qd}	Gate to Drain "Miller" Charge		-	24	_	nC
WITCHING O	CHARACTERISTICS					
t _{d(on)}	Turn-On Delay	V _{DD} = 40 V, I _D = 80 A,	-	39	-	ns
t _r	Rise Time	V _{GS} = 10 V, R _{GEN} = 6 Ω	-	63	-	ns
t _{d(off)}	Turn-Off Delay		-	61	_	ns
t _f	Fall Time	1	-	33	-	ns
DRAIN-SOUF	RCE DIODE CHARACTERISTIC		-			
V _{SD}	Source to Drain Diode Voltage	I _{SD} = 80 A, V _{GS} = 0 V	-	-	1.25	V
		I _{SD} = 40 A, V _{GS} = 0 V	-	_	1.2	V
t _{rr}	Reverse Recovery Time	$I_{F} = 80 \text{ A}, \text{ d}I_{SD}/\text{d}t = 100 \text{ A}/\mu\text{s},$	-	83	-	ns
Q _{rr}	Reverse Recovery Charge	$V_{DD} = 64 V$	-	118	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. The maximum value is specified by design at T_J = 175°C. Product is not tested to this condition in production.

TYPICAL CHARACTERISTICS



10⁻² t, RECTANGULAR PULSE DURATION(s)

10⁻¹

10°

10¹

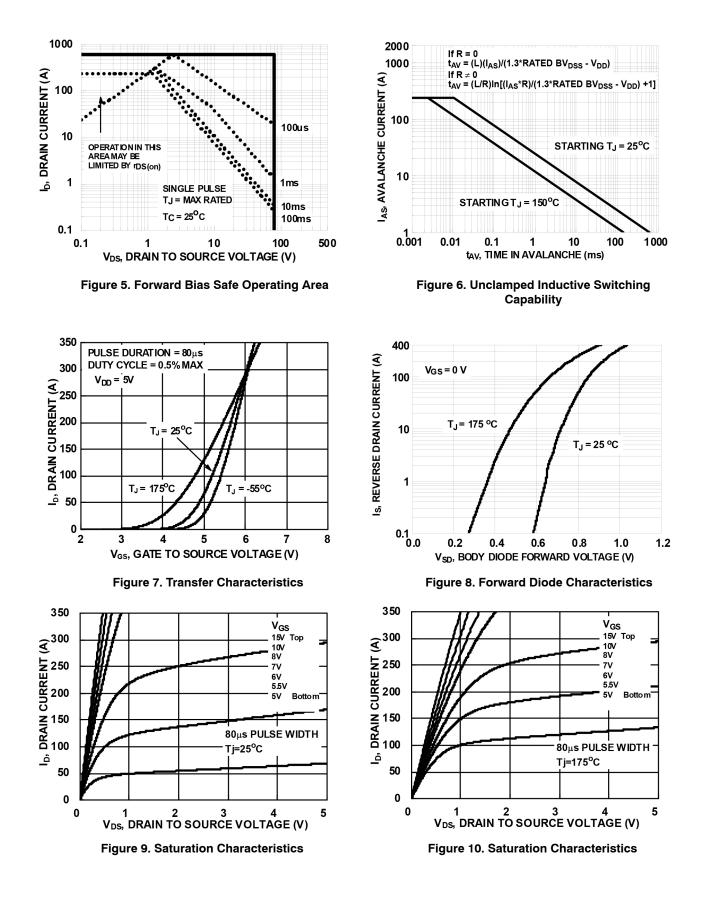
10⁻⁵

10-4

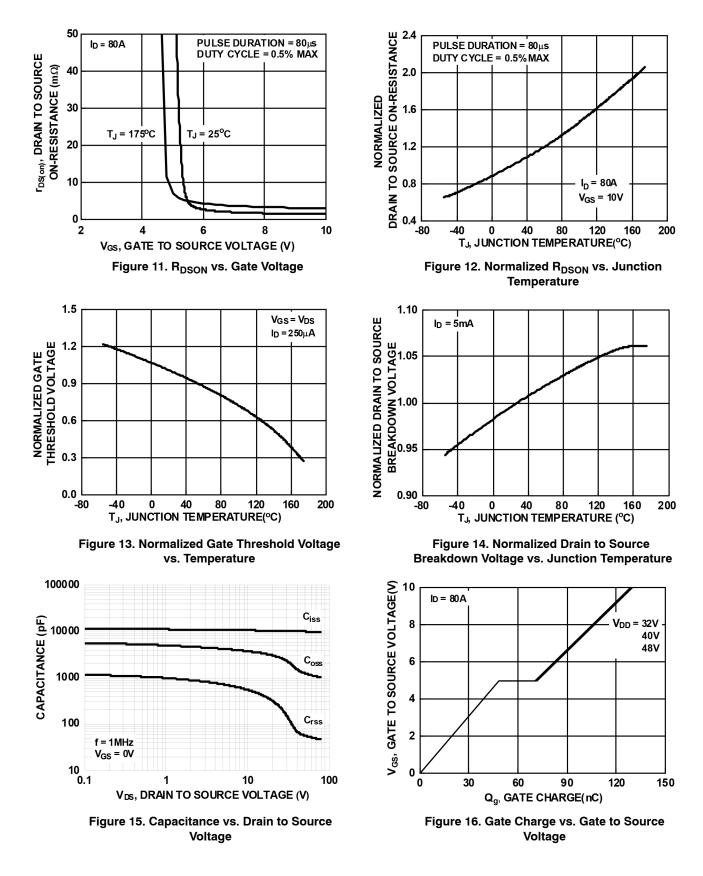
10⁻³

Figure 4. Peak Current Capability

TYPICAL CHARACTERISTICS (continued)



TYPICAL CHARACTERISTICS (continued)



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